

DK-107172-UL

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Product

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Intel[®] NUC (computer)

INTEL CORPORATION 2200 MISSION COLLEGE BLVD SANTA CLARA, CA 95054-1537 USA

INTEL CORPORATION 2200 MISSION COLLEGE BLVD SANTA CLARA, CA 95054-1537 USA

GOLDEN ELITE TECHNOLOGY (SHEN ZHEN) LTD 1 NAN HUAN RD SHAJING BAO AN SHENZHEN GUANGDONG 518104 CHINA

Additional Information on page 2 19 Vdc, 4.74 A or 19 Vdc, 6.32 A

Ratings and principal characteristics

Trademark / Brand (if any)



Type of Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

xNUC11xPAKx, xNUC11xPAHx, xNUC11xPAQx (where x can be a combination of alphanumeric characters, none or blank)

Additionally evaluated to EN 60950-1:2006/A11:2009/A1:2010/A12:2011/A2:2013 National Difference specified in the CB Test Report

IEC 60950-1:2005/AMD1:2009, IEC 60950-1:2005/AMD2:2013, IEC 60950-1:2005

ATTCB109125 issued on 2020-12-07

This CB Test Certificate is issued by the National Certification Body



UL (US), 333 Pfingsten Rd IL 60062, Northbrook, USA

UL (Demko), Borupvang 5A DK-2750 Ballerup, DENMARK

UL (JP), Marunouchi Trust Tower Main Building 6F, 1-8-3 Marunouchi, Chiyoda-ku, Tokyo 100-0005, JAPAN UL (CA), 7 Underwriters Road, Toronto, M1R 3B4 Ontario, CANADA

For full legal entity names see www.ul.com/ncbnames

Date: 2020-12-14

Signature:

Jan-Erik Storgaard